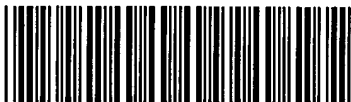


Search Notes

Application/Control No.

10/666,860

Examiner

Dah-Wei D. Yuan

Applicant(s)/Patent under
Reexamination

TSUKAMOTO ET AL.

Art Unit

1745

SEARCHED

Class	Subclass	Date	Examiner
429	94	11/9/2006	DWY
429	623.1	11/9/2006	DWY
429	623.3	11/9/2006	DWY
429	623.5	11/9/2006	DWY

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	11/9/2006	DWY